

**Search Notes**

Application/Control No.

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Examiner

M. Lee

Applicant(s)/Patent under  
Reexamination

ZHU ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	607, 618, 619, 620, 621, 622	9/26/2006	ML
	627		
382	625		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference search history printout		9/26/2006	ML

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	9/26/2006	ML